

Appl. No. : 10/571,183
Confirmation No. : 9612
Applicant : Bateman et al.

Filed : March 9, 2006
Title : IONISING PARTICLE
ANALYSER FOR THE
SEPARATION OF THE
FLUORESCENT YIELD AND
THE TOTAL ELECTRON
YIELD IN EXTENDED X-RAY
ABSORPTION FINE
STRUCTURE
MEASUREMENTS

TC/A.U. : 2881
Examiner : David A. Vanore

Docket No. : 063511-9088-00

Customer No. : 023409

Mail Stop Issue Fee
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

COMMENTS ON THE STATEMENT OF REASONS FOR ALLOWANCE
UNDER 37 C.F.R. § 1.104(e)

Sir:

This communication is in response to the Examiner's Statement of Reasons for Allowance set forth in the Notice of Allowance and Fee(s) Due dated June 18, 2008.

Applicants respectfully submit that the Examiner has identified only a few of the separate and independent reasons for allowance of independent Claims 1 and 15, and, therefore, for allowance of dependent Claims 2-14 and 16-17. Applicants also respectfully submit that Claims 2-14 and 16-17 are allowable for additional separate and independent reasons. The independent claims (Claims 1 and 15) include additional patentable features and/or combinations of features not mentioned by the Examiner. Similarly, the dependent claims (Claims 2-14 and 16-17)

include additional patentable features and/or combinations of features not mentioned by the Examiner.

Respectfully submitted,



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Docket No. 063511-9088-00
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